

<b>Notice of References Cited</b>	Application/Control No. 09/994,585	Applicant(s)/Patent Under Reexamination LEVINSON, DOUGLAS	
	Examiner Jon D. Epperson	Art Unit 1639	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	WO 01/51919	01-2001	WIPO	Levinson et al.	G01N 30/00
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**NON-PATENT DOCUMENTS**

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	U	Klein, J.; Lehmann, C. W.; Schmidt, H.-W.; Maier, W. F. "Combinatorial Material Libraries on the Microgram Scale with an Example of Hydrothermal Synthesis" Angew. Chem. Int. Ed. 1998, 37(24), 3369-3372 /
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	W	Emiabata-Smith, D. F.; Crookes, D. L.; Owen, M.R. "A practical approach to accelerated process screening and optimization" Organic Process Research & Development 1999, 3, 281-288 /
*	X	Findlay, W. P.; Bugay, D. E. "Utilization of Fourier transform-Raman spectroscopy for the study of pharmaceutical crystal forms" Journal of Pharmaceutical and Biomedical Analysis 1998, 16, 921-930

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.